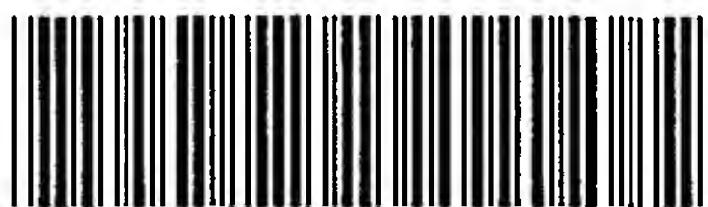


## **Search Notes**



<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
10/711,953	CLINE ET AL.
<b>Examiner</b>	<b>Art Unit</b>
Eric B. Chen	1765

SEARCHED

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

# SEARCH NOTES (INCLUDING SEARCH STRATEGY)